Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/975,386	KNAPP, KENNETH DAVID	
Examiner	Art Unit	
Phi D. A	3637	

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Subclass	Date	Examiner
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
All tece	/	11/106		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
see attached	11/1/2006	PA		
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